

1.6 TO 2.7 GBPS TRANSCEIVER

Check for Samples: TLK2711A

FEATURES

- 1.6 to 2.7 Gigabits Per Second (Gbps) Serializer/Deserializer
- **Hot-Plug Protection**
- **High-Performance 80-Pin BGA Microstar** • Junior[™] Package (GQE)
- 2.5-V Power Supply for Low Power Operation
- **Programmable Preemphasis Levels on Serial** • Output
- Interfaces to Backplane, Copper Cables, or **Optical Converters**
- On-Chip 8-bit/10-bit Encoding/Decoding, Comma Detect

- **On-Chip PLL Provides Clock Synthesis From** • Low-Speed Reference
- **Receiver Differential Input Thresholds 200 mV** Minimum
- Low Power: < 500 mW .
- **3 V Tolerance on Parallel Data Input Signals**
- **16-Bit Parallel TTL Compatible Data Interface** •
- Ideal for High-Speed Backplane Interconnect and Point-to-Point Data Link
- Industrial Temperature Range (-40°C to 85°C **RCP Package Only)**
- Loss of Signal (LOS) Detection
- Integrated 50-Ω Termination Resistors on RX •

DESCRIPTION

The TLK2711A is a member of the WizardLink transceiver family of multigigabit transceivers, intended for use in ultrahigh-speed bidirectional point-to-point data transmission systems. The TLK2711A supports an effective serial interface speed of 1.6 Gbps to 2.7 Gbps, providing up to 2.16 Gbps of data bandwidth.

The primary application of this chip is to provide very high-speed I/O data channels for point-to-point baseband data transmission over controlled impedance media of approximately 50Ω. The transmission media can be printed-circuit board, copper cables, or fiber-optic cable. The maximum rate and distance of data transfer is dependent upon the attenuation characteristics of the media and the noise coupling to the environment.

This device can also be used to replace parallel data transmission architectures by providing a reduction in the number of traces, connector terminals, and transmit/receive terminals. Parallel data loaded into the transmitter is delivered to the receiver over a serial channel, which can be a coaxial copper cable, a controlled impedance backplane, or an optical link. It is then reconstructed into its original parallel format. It offers significant power and cost savings over parallel solutions, as well as scalability for higher data rates in the future.

The TLK2711A performs data conversion parallel-to-serial and serial-to-parallel. The clock extraction functions as a physical layer interface device. The serial transceiver interface operates at a maximum speed of 2.7 Gbps. The transmitter latches 16-bit parallel data at a rate based on the supplied reference clock (TXCLK). The 16-bit parallel data is internally encoded into 20 bits using an 8-bit/10-bit (8b/10b) encoding format. The resulting 20-bit word is then transmitted differentially at 20 times the reference clock (TXCLK) rate. The receiver section performs the serial-to-parallel conversion on the input data, synchronizing the resulting 20-bit wide parallel data to the recovered clock (RXCLK). It then decodes the 20-bit wide data using the 8-bit/10-bit decoding format resulting in 16 bits of parallel data at the receive data terminals (RXD0-15). The outcome is an effective data payload of 2 Gbps to 2.5 Gbps (16 bits data x the frequency).

The TLK2711A is provided in two packages options: a 80-pin ball grid array MicroStar Junior package and a 64pin VQFP (RCP) package.

The TLK2711A provides an internal loopback capability for self-test purposes. Serial data from the serializer is passed directly to the deserializer, providing the protocol device with a functional self-check of the physical interface.



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TLK2711A

SLLS908B-JULY 2008-REVISED OCTOBER 2012





These devices have limited built-in ESD protection. The leads should be shorted together or the device placed in conductive foam during storage or handling to prevent electrostatic damage to the MOS gates.

DESCRIPTION (CONTINUED)

The TLK2711A has a loss of signal (LOS) detection circuit for conditions where the incoming signal no longer has a sufficient voltage amplitude to keep the clock recovery circuit in lock.

The TLK2711A allows users to implement redundant ports by connecting receive data bus terminals from two TLK2711A devices together. Asserting the LCKREFN to a low state will cause the receive data bus terminals, RXD[0:15], RXCLK, RKLSB, and RKMSB to go to a high-impedance state. This places the device in a transmit-only mode since the receiver is not tracking the data.

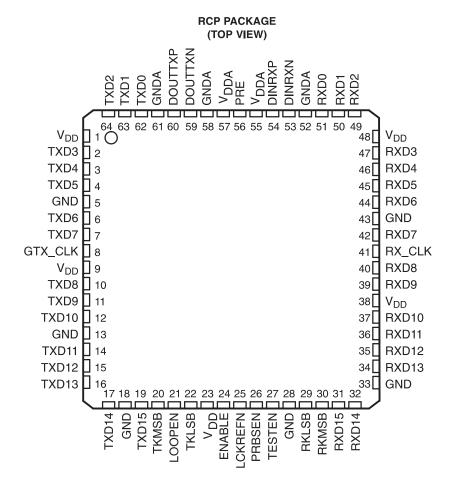
The TLK2711A uses a 2.5-V supply. The I/O section is 3 V compatible. With the 2.5-V supply the chipset is very power efficient, consuming less than 450 mW typically. The TLK2711A is characterized for operation from –40°C to 85°C (RCP only).

The TLK2711A is designed to be hot-plug capable. An on-chip power-on reset circuit holds the RXCLK low and goes to high impedance on the parallel side output signal terminals as well as TXP and TXN during power up.

9	8	7	6	5	4	3	2	1	_
GND	TXD1	ТХР	TXN	PRE	RXP	RXN	RXD1	GND	J
TXD3	TXD2	TXD0	GNDA	VDDA	GNDA	RXD0	RXD2	RXD3	н
TXD5	TXD4	VDD	VDD	VDD	GND	GND	RXD4	RXD5	G
TXD6	TXD7	VDD	VDD	VDD	GND	GND	RXD6	RXD7	F
TXCLK	VDD	VDD	VDD	VDD	GND	GND	RXCLK	RXD8	E
TXD8	TXD9	VDD	VDD	VDD	GND	GND	RXD11	RXD9	D
TXD10	TXD11	VDD	VDD	VDD	GND		RXD12	RXD10	c
TXD12	TXD13	TKMSB	LOOPEN	LCKREFN	TESTEN	RKMSB	RXD14	RXD13	в
GND	TXD14	TXD15	TKLSB	ENABLE	PRBSEN	RKLSB	RXD15	GND	A
9	8	7	6	5	4	3	2	1	-

GQE PACKAGE (TOP VIEW)





TLK2711A

SLLS908B-JULY 2008-REVISED OCTOBER 2012

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INSTRUMENTS

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BLOCK DIAGRAM

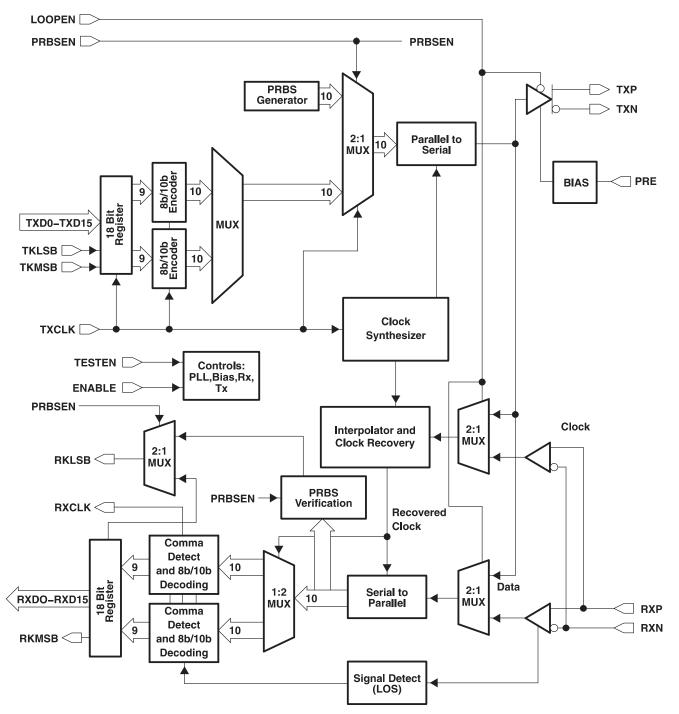


Figure 1. TLK2711A Block Diagram



TERMINAL FUNCTIONS

TERMINAL						
NAME NO.		I/O	DESCRIPTION			
NAME	GQE	RCP				
ENABLE	A5	24	l ⁽¹⁾	Device enable. When this terminal is held low, the device is placed in power-down mode. Only the signal detect circuit on the serial receive pair is active. When asserted high while the device is in power-down mode, the transceiver goes into power-on reset before beginning normal operation.		
GND	A1, J1, D3, E3, F3, G3, C4, D4, E4, F4, G4, A9, J9	5, 13, 18, 28, 33, 43		Digital logic ground. Provides a ground for the logic circuits and digital I/O buffers.		
GNDA	H4, H6	52, 58, 61		Analog ground. GNDA provides a ground reference for the high-speed analog circuits, RX and TX.		
LCKREFN	B5	25	I ⁽¹⁾	Lock to reference. When LCKREFN is low, the receiver clock is frequency locked to TXCLK. This places the device in a transmit only mode since the receiver is not tracking the data. When LCKREFN is asserted low, the receive data bus terminals, RXD[0:15], RXCLK and RKLSB, RKMSB are in a high-impedance state.		
				When LCKREFN is deasserted high, the receiver is locked to the received data stream.		
LOOPEN	B6	21	I ⁽²⁾	Loop enable. When LOOPEN is active high, the internal loop-back path is activated. The transmitted serial data is directly routed internally to the inputs of the receiver. This provides a self-test capability in conjunction with the protocol device. The TXP and TXN outputs are held in a high-impedance state during the loop-back test. LOOPEN is held low during standard operational state with external serial outputs and inputs active.		
PRE	J5	56	I ⁽²⁾	Preemphasis control. Selects the amount of preemphasis to be added to the high speed serie output drivers. Left low or unconnected, 5% preemphasis is added. Pulled high, 20% preemphasis is added.		
PRBSEN	A4	26	I ⁽²⁾	PRBS test enable. When asserted high results of pseudo random bit stream (PRBS) tests can be monitored on the RKLSB terminal. A high on RKLSB indicates that valid PRBS is being received.		
RKLSB	A3	29	0	K-Code indicator/PRBS test results. When RKLSB is asserted high, an 8-bit/10-bit K code was received and is indicated by data bits RXD0–RXD7. When RKLSB is asserted low an 8-bit/10-bit D code is received and is presented on data bits RXD0–RXD7.		
				When PRBSEN is asserted high this pin is used to indicate status of the PRBS test results (high = pass).		
RKMSB	B3	30	0	K-code indicator. When RKMSB is asserted high an 8-bit/10-bit K code was received and is indicated by data bits RXD8–RXD15. When RKMSB is asserted low an 8-bit/10-bit D code was received and is presented on data bits RXD8–RXD15. If the differential signal on RXN and RXP drops below 200 mV, then RXD [0:15], RKLSB, and RKMSB are all asserted high.		
RXCLK RX_CLK	E2	41	0	Recovered clock. Output clock that is synchronized to RXD [09], RKLSB, and RKMSB. RXCLK is the recovered serial data rate clock divided by 20. RXCLK is held low during power-on reset.		

(1) (2)

Internal 10k pullup Internal 10k pulldown

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TERMINAL FUNCTIONS (Continued)

TERMINAL						
NO.		I/O	DESCRIPTION			
NAME	GQE	RCP				
RXD0	H3	51	0	Receive data bus. These outputs carry 16-bit parallel data output from the transceiver to the		
RXD1	J2	50		protocol device, synchronized to RXCLK. The data is valid on the rising edge of RXCLK as shown		
RXD2	H2	49		in Figure 5. These terminals are in high-impedance state during power-on reset.		
RXD3	H1	47				
RXD4	G2	46				
RXD5	G1	45				
RXD6	F2	44				
RXD7	F1	42				
RXD8	E1	40				
RXD9	D1	39				
RXD10	C1	37				
RXD11	D2	36				
RXD12	C2	35				
RXD13	B1	34				
RXD14	B2	32				
RXD15	A2	31				
RXN	J3					
RXP	J4			Serial receive inputs. RXP and RXN together are the differential serial input interface from a copper		
DINRXN		53	I	or an optical I/F module.		
DINRXP		54				
TESTEN	B4	27	I ⁽¹⁾	Test mode enable. This terminal should be left unconnected or tied low.		
			(2)			
TKLSB	A6	22	1	K-code generator (LSB). When TKLSB is high, an 8-bit/10-bit K code is transmitted as controlled by data bits TXD0–TXD7. When TKLSB is low an 8-bit/10-bit D code is transmitted as controlled by data bits TXD0–TXD7.		
TKMSB	B7	20	I ⁽¹⁾	K-code generator (MSB). When TKMSB is high an 8-bit/10-bit K code is transmitted as controlled by data bits TXD8–TXD15. When TKMSB is low an 8-bit/10-bit D code is transmitted as controlled by data bits TXD8–TXD15.		
TXCLK	E9			Reference clock. TXCLK is a continuous external input clock that synchronizes the transmitter		
GTX_CLK		8	I	interface signals TKMSB, TKLSB and TXD [015]. The frequency range of TXCLK is 80 MHz to 135 MHz. The transmitter uses the rising edge of this clock to register the 16-bit input data TXD [015] for serialization.		
TXD0	H7	62	I	Transmit data bus. These inputs carry the 16-bit parallel data output from a protocol device to the		
TXD1	J8	63		transceiver for encoding, serialization, and transmission. This 16-bit parallel data clocked into the		
TXD2	H8	64		transceiver on the rising edge of TXCLK as shown in Figure 2.		
TXD3	H9	2				
TXD4	G8	3				
TXD5	G9	4				
TXD6	F9	6				
TXD7	F8	7				
TXD8	D9	10				
TXD9	D8	11				
TXD10	C9	12				
TXD11	C8	14				
TXD12	B9	15				
TXD13	B8	16				
TXD14	A8	17				
TXD15	A7	19				
TXN	J6			Serial transmit outputs. TXP and TXN are differential serial outputs that interface to copper or an		
TXP	J7			optical I/F module. These terminals transmit NRZ data at a rate of 20 times the TXCLK value. TXP		
DOUTTXN		59	0	and TXN are put in a high-impedance state when LOOPEN is high and are active when LOOPEN is		
DOUTTXP		60		low. During power-on reset these terminals are high impedance.		
50011/1	1	50				

(1) Internal 10k pulldown(2) Internal 10k pullup



TERMINAL FUNCTIONS (Continued)

	TERMINAL			
	NOI/O		I/O	DESCRIPTION
NAME	GQE	RCP		
VDD	C5, D5, E5, F5, G5, C6, D6, E6, F6, G6, C7, D7, E7, F7, G7, E8	1, 9, 23, 38, 48		Digital logic power. Provides power for all digital circuitry and digital I/O buffers.
VDDA	H5	55, 57		Analog power. V_{DDA} provides a supply reference for the high-speed analog circuits, receiver and transmitter.

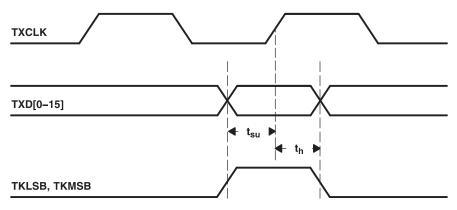
DETAILED DESCRIPTION

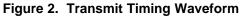
TRANSMIT INTERFACE

The transmitter portion registers valid incoming 16-bit wide data (TXD[0:15]) on the rising edge of the TXCLK. The data is then 8-bit/10-bit encoded, serialized, and transmitted sequentially over the differential high-speed I/O channel. The clock multiplier multiplies the reference clock (TXCLK) by a factor of 10 times, creating a bit clock. This internal bit clock is fed to the parallel-to-serial shift register which transmits data on both the rising and falling edges of the bit clock, providing a serial data rate that is 20 times the reference clock. Data is transmitted LSB (TXD0) first.

transmit data bus

The transmit bus interface accepts 16-bit single-ended TTL parallel data at the TXD[0:15] terminals. Data and K-code control is valid on the rising edge of the TXCLK. The TXCLK is used as the word clock. The data, K-code, and clock signals must be properly aligned as shown in Figure 2. Detailed timing information can be found in the electrical characteristics table.

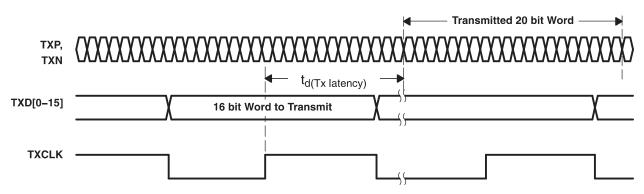




Transmission Latency

The data transmission latency of the TLK2711A is defined as the delay from the initial 16-bit word load to the serial transmission of bit 0. The transmit latency is fixed once the link is established. However, due to silicon process variations and implementation variables such as supply voltage and temperature, the exact delay varies slightly. The minimum transmit latency $t_{d(Tx | atency)}$ is 34 bit times; the maximum is 38 bit times. Figure 3 illustrates the timing relationship between the transmit data bus, the TXCLK, and the serial transmit terminals.







8-Bit/10-Bit Encoder

All true serial interfaces require a method of encoding to insure minimum transition density so that the receiving PLL has a minimal number of transitions to stay locked on. The encoding scheme maintains the signal dc balance by keeping the number of ones and zeros the same. This provides good transition density for clock recovery and improves error checking. The TLK2711A uses the 8-bit/10-bit encoding algorithm that is used by fibre channel and gigabit ethernet. This is transparent to the user, as the TLK2711A internally encodes and decodes the data such that the user reads and writes actual 16-bit data.

The 8-bit/10-bit encoder converts 8-bit wide data to a 10-bit wide encoded data character to improve its transmission characteristics. Since the TLK2711A is a 16-bit wide interface, the data is split into two 8-bit wide bytes for encoding. Each byte is fed into a separate encoder. The encoding is dependent upon two additional input signals, the TKMSB and TKLSB.

TKLSB	TKMSB	16 BIT PARALLEL INPUT			
0	0	Valid data on TXD(0-7),	Valid data TXD(8–15)		
0	1	Valid data on TXD(0-7),	K code on TXD(8–15))		
1	0	K code on TXD(0-7),	Valid data on TXD(8–15)		
1	1	K code on TXD(0-7),	K code on TXD(8–15)		

Table 1. Transmit Data Controls

PRBS Generator

The TLK2711A has a built-in 2⁷-1 PRBS (pseudorandom bit stream) function. When the PRBSEN terminal is forced high, the PRBS test is enabled. A PRBS is generated and fed into the 10-bit parallel-to-serial converter input register. Data from the normal input source is ignored during the PRBS mode. The PRBS pattern is then fed through the transmit circuitry as if it were normal data and sent out to the transmitter. The output can be sent to a BERT (bit error rate tester), the receiver of another TLK2711A, or looped back to the receive input. Since the PRBS is not really random but a predetermined sequence of ones and zeroes, the data can be captured and checked for errors by a BERT.

Parallel-to-Serial

The parallel-to-serial shift register takes in the 20-bit wide data word multiplexed from the two parallel 8-bit/10-bit encoders and converts it to a serial stream. The shift register is clocked on both the rising and falling edge of the internally generated bit clock, which is 10 times the TXCLK input frequency. The LSB (TXD0) is transmitted first.



High-Speed Data Output

The high-speed data output driver consists of a voltage mode logic (VML) differential pair optimized for a $50-\Omega$ impedance environment. The magnitude of the differential pair signal swing is compatible with pseudo emitter coupled logic (PECL) levels when ac-coupled. The line can be directly-coupled or ac-coupled. Refer to Figure 11 and Figure 12 for termination details. The outputs also provide preemphasis to compensate for ac loss when driving a cable or PCB backplane trace over a long distance (see Figure 4). The level of pre-emphasis is controlled by PRE as shown in Table 2.

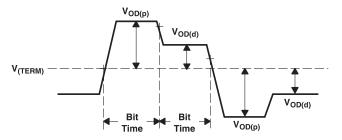


Figure 4. Output Voltage Under Pre-emphasis (|VTXP–VTXN|)

Table 2.	Programmable	Pre-emphasis
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TLK2711A

SLLS908B-JULY 2008-REVISED OCTOBER 2012

PRE	PRE-EMPHASIS LEVEL(%) V _{OD(P)} , V _{OD(D)} ⁽¹⁾
0	5%
1	20%

 V_{OD(p)}: Voltage swing when there is a transition in the data stream.
V_{OD(d)}: Voltage swing when there is no transition in the data stream.

Receive Interface

The receiver portion of the TLK2711A accepts 8-bit/10-bit encoded differential serial data. The interpolator and clock recovery circuit locks to the data stream and extract the bit rate clock. This recovered clock is used to retime the input data stream. The serial data is then aligned to two separate 10-bit word boundaries, 8-bit/10-bit decoded and output on a 16-bit wide parallel bus synchronized to the extracted receive clock. The data is received LSB (RXD0) first.

Receive Data Bus

The receive bus interface drives 16-bit wide single-ended TTL parallel data at the RXD[0:15] terminals. Data is valid on the rising edge of the RXCLK. The RXCLK is used as the recovered word clock. The data, RKLSB, RKMSB, and clock signals are aligned as shown in Figure 5. Detailed timing information can be found in the switching characteristics table.

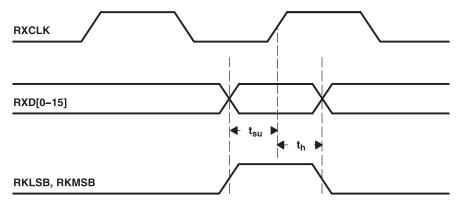


Figure 5. Receive Timing Waveform

Data Reception Latency

The serial-to-parallel data receive latency is the time from when the first bit arrives at the receiver until it is output in the aligned parallel word. The receive latency is fixed once the link is established. However, due to silicon process variations and implementation variables such as supply voltage and temperature, the exact delay varies slightly. The minimum receive latency $t_{d(Rx | atency)}$ is 76 bit times; the maximum is 107 bit times. Figure 6 illustrates the timing relationship between the serial receive terminals, the recovered word clock (RXCLK), and the receive data bus.

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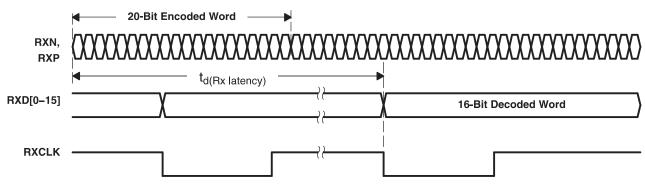


Figure 6. Receiver Latency

Serial-to-Parallel

Serial data is received on the RXP and RXN terminals. The interpolator and clock recovery circuit locks to the data stream if the clock to be recovered is within 200 PPM of the internally generated bit rate clock. The recovered clock is used to retime the input data stream. The serial data is then clocked into the serial-to-parallel shift registers. The 10-bit wide parallel data is then multiplexed and fed into two separate 8-bit/10-bit decoders where the data is then synchronized to the incoming data stream word boundary by detection of the comma 8-bit/10-bit synchronization pattern.

Common Detect and 8-Bit/10-Bit Decoding

The TLK2711A has two parallel 8-bit/10-bit decode circuits. Each 8-bit/10-bit decoder converts 10 bit encoded data (half of the 20-bit received word) back into 8 bits. The comma detect circuit is designed to provide for byte synchronization to an 8-bit/10-bit transmission code. When parallel data is clocked into a parallel to serial converter, the byte boundary that was associated with the parallel data is now lost in the serialization of the data. When the serial data is received and converted to parallel format again, a method is needed to recognize the byte boundary. Generally this is accomplished through the use of a synchronization pattern. This is generally a unique pattern of 1's and 0's that either cannot occur as part of valid data or is a pattern that repeats at defined intervals. The 8-bit/10-bit encoding contains a character called the comma (b0011111 or b1100000), which is used by the comma detect circuit on the TLK2711A to align the received serial data back to its original byte boundary. The decoder detects the comma, generating a synchronization signal aligning the data to their 10-bit data. The output from the two decoders is latched into the 16-bit register synchronized to the recovered parallel data clock (RXCLK) and output valid on the rising edge of the RXCLK.

NOTE

The TLK2711A only achieves byte alignment on the 0011111 comma.

Decoding provides two additional status signals, RKLSB and RKMSB. When RKLSB is asserted , an 8-bit/10-bit K code was received and the specific K code is presented on the data bits RXD0–RXD7; otherwise, an 8-bit/10-bit D code was received. When RKMSB is asserted, an 8-bit/10-bit K code was received and the specific K-code is presented on data bits RXD8–RXD15; otherwise, an 8-bit/10-bit D code was received (see Table 3). The valid K codes the TLK2711A decodes are provided in Table 4. An error detected on either byte, including K codes not in Table 4, causes that byte only to indicate a K0.0 code on the RK×SB and associated data pins, where K0.0 is known to be an invalid 8-bit/10-bit code. A loss of input signal causes a K31.7 code to be presented on both bytes, where K31.7 is also known to be an invalid 8-bit/10-bit code.

RKLSB	RKMSB	DECODED 20 BIT OUTPUT					
0	0	Valid data on RXD(0-7),	Valid data RXD(8–15)				
0	1	Valid data on RXD(0-7),	K code on RXD(8–15))				
1	0	K code on RXD(0-7),	Valid data on RXD(8–15)				
1	1	K code on RXD(0-7),	K code on RXD(8–15)				

Table 3. Receive Status Signals

Table 4. Valid K Characters

K CHARACTER	RECEIVE DATA BUS (RXD[7–0]) OR (RXD[15–8])		
K28.0	000 11100		
K28.1 ⁽¹⁾	001 11100		
K28.2	010 11100		
K28.3	011 11100		
K28.4	100 11100		
K28.5 ⁽¹⁾	101 11100		
K28.6	110 11100		
K28.7 ⁽¹⁾	111 11100		
K23.7	111 10111		
K27.7	111 11011		
K29.7	111 11101		
K30.7	111 11110		

(1) Should only be present on RXD[7-0] when in running disparity < 0.

Power Down Mode

When the ENABLE pin is pulled low, the TLK2711A goes into power-down mode. In the power-down mode, the serial transmit pins (TXN), the receive data bus pins (RXD[0:15]), and RKLSB goes into a high-impedance state. In the power-down condition, the signal detection circuit draws less than 15 mW. When the TLK2711A is in the power-down mode, the clock signal on the TXCLK terminal must be provided.

Loss of Signal Detection

The TLK2711A has a loss of signal detection circuit for conditions where the incoming signal no longer has a sufficient voltage level to keep the clock recovery circuit in lock. The signal detection circuit is intended to be an indication of gross signal error conditions, such as a detached cable or no signal being transmitted, and not an indication of signal coding health. The TLK2711A reports this condition by asserting RKLSB, RKMSB and RXD[0:15] terminals to a high state. As long as the differential signal is above 200 mV in differential magnitude, the LOS circuit does not signal an error condition.

PRBS Verification

The TLK2711A also has a built-in BERT function in the receiver side that is enabled by the PRBSEN. It can check for errors and report the errors by forcing the RKLSB terminal low.

Reference Clock Input

The reference clock (TXCLK) is an external input clock that synchronizes the transmitter interface. The reference clock is then multiplied in frequency 10 times to produce the internal serialization bit clock. The internal serialization bit clock is frequency-locked to the reference clock and used to clock out the serial transmit data on both its rising and falling edges, providing a serial data rate that is 20 times the reference clock.

Operating Frequency Range

The TLK2711A can operate at a serial data rate from 1.6 Gbps to 2.7 Gbps. To achieve these serial rates, TXCLK must be within 80 MHz to 135 MHz. The TXCLK must be within ± 100 PPM of the desired parallel data rate clock.

TLK2711A

SLLS908B-JULY 2008-REVISED OCTOBER 2012



Testability

The TLK2711A has a comprehensive suite of built-in self-tests. The loopback function provides for at-speed testing of the transmit/receive portions of the circuitry. The enable terminal allows for all circuitry to be disabled so that a quiescent current test can be performed. The PRBS function allows for BIST (built-in self-test).

Loopback Testing

The transceiver can provide a self-test function by enabling (LOOPEN) the internal loop-back path. Enabling this terminal causes serial-transmitted data to be routed internally to the receiver. The parallel data output can be compared to the parallel input data for functional verification. (The external differential output is held in a high-impedance state during the loopback testing.)

Built-In Self-Test (BIST)

The TLK2711A has a BIST function. By combining PRBS with loopback, an effective self-test of all the circuitry running at full speed can be realized. The successful completion of the BIST is reported on the RKLSB terminal.

Power-On Reset

Upon application of minimum valid power, the TLK2711A generates a power-on reset. During the power-on reset the RXD[0..15], RKLSB, and RKMSB signal terminals go to a high-impedance state. The RXCLK is held low. The length of the power-on reset cycle is dependent upon the TXCLK frequency, but is less than 1 ms.

ABSOLUTE MAXIMUM RATINGS

over operating free-air temperature (unless otherwise noted)⁽¹⁾

			VALUE	UNIT
V _{DD}	Supply voltage ⁽²⁾		-0.3 to 3	V
	Voltage range at TXD[015], ENA PRBSEN, LCKREFN, PRE	BLE, TXCLK, TKMSB, TKLSB, LOOPEN,	-0.3 to 4	V
	Voltage range at any other termination	al except above	-0.3 to V _{DD} +0.3	V
P _D	Package power dissipation	See Dissipation Rating Table		
T _{stg}	Storage temperature		-65 to 150	°C
		НВМ	4	kV
	Electrostatic discharge	CDM	1.5	kV
-	Characterized free-air operating	RCP	-40 to 85	°C
IA	temperature range	GQE	0 to 70	°C
	Lead temperature 1,6 mm (1/16 ir	nch) from case for 10 seconds	260	°C

(1) Stresses beyond those listed under absolute maximum ratings may cause permanent damage to the device. These are stress ratings only, and functional operation of the device at these or any other conditions beyond those indicated under recommended operating conditions is not implied. Exposure to absolute-maximum-rated conditions for extended periods may affect device reliability.

(2) All voltage values, except differential I/O bus voltages, are stated with respect to network ground.

DISSIPATION RATINGS⁽¹⁾

PACKAGE	θ _{JA}	θ _{JC}	T _A = 25℃
	(°C/W)	(°C/W)	POWER RATING
GQE	37.8	4.56	3.3 W

(1) This data was taken using 2-oz trace and copper pad that is soldered directly to the JEDEC standard 4-layer, 3-inch x 3-inch PCB.

DISSIPATION RATINGS

PACKAGE	T _A ≤ 25°C	DERATING FACTOR ⁽¹⁾	T _A = 70°C
	POWER RATING	ABOVE T _A = 25°C	POWER RATING
RCP64 ⁽²⁾	5.25 W	46.58 mW/°C	2.89 W

(1) This is the inverse of the traditional junction-to-ambient thermal resistance ($R_{\theta JA}$).

(2) 2 oz. Trace and copper pad with solder.

DISSIPATION RATINGS (continued)

PACKAGE	T _A ≤ 25°C POWER RATING	DERATING FACTOR ⁽¹⁾ ABOVE T _A = 25°C	T _A = 70°C POWER RATING
RCP64 ⁽³⁾	3.17 W	23.70 mW/°C	1.74 W
RCP64 ⁽⁴⁾	2.01 W	13.19 mW/°C	1.11 W

(3) 2 oz. Trace and copper pad without solder.

(4) Standard JEDEC High-K board.

For more information, refer to TI application note PowerPAD[™] Thermally Enhanced package, TI literature number SLMA002.

ELECTRICAL CHARACTERISTICS

over recommended operating conditions

	PARAMETER	TEST CONDITIONS	MIN	NOM	MAX	UNIT
V_{DD}	Supply voltage		2.3	2.5	2.7	V
	Supply surrent	Frequency = 1.6 Gbps, PRBS pattern		105		
ICC	D Supply voltage Supply current Power dissipation Shutdown current PLL startup lock time Data acquisition time	Frequency = 2.7 Gbps, PRBS pattern		156		mA
	Power dissipation	Frequency = 1.6 Gbps, PRBS pattern		262		
P_D		Frequency = 2.7 Gbps, PRBS pattern		390		mW
		Frequency = 2.7 Gbps, worst case pattern ⁽¹⁾			550	
	Shutdown current	Enable = 0, V_{DDA} , V_{DD} terminals, V_{DD} = MAX		3		mA
	PLL startup lock time	V_{DD} , V_{DDC} = 2.3 V		0.1	0.4	ms
	Data acquisition time			1024		Bits
T _A	Operating free-air temperature		-40		85	°C

(1) Worst case pattern is a pattern that creates a maximum transition density on the serial transceiver.

REFERENCE CLOCK (TXCLK)TIMING REQUIREMENTS

over recommended operating conditions (unless otherwise noted)

PARAMETER	TEST CONDITIONS	MIN	TYP	MAX	UNIT
Frequency	Minimum data rate	Typ-0.01%	80	Typ+0.01%	MHz
Frequency	Maximum data rate	Typ-0.01%	135	Typ+0.01%	MHz
Frequency tolerance		-100		100	ppm
Duty cycle		40%	50%	60%	
Jitter	Peak-to-peak			40	ps

TTL INPUT ELECTRICAL CHARACTERISTICS

over recommended operating conditions (unless otherwise noted), TTL signals: TXDO-TXD15, TXCLK, LOOPEN, LCKREFN, ENABLE, PRBS_EN, TKLSB, TKMSB, PRE

	PARAMETER	TEST CONDITIONS	MIN	TYP	MAX	UNIT
V_{IH}	High-level input voltage	See Figure 7	1.7		3.6	V
V_{IL}	Low-level input voltage	See Figure 7			0.80	V
I _{IH}	Input high current	$V_{DD} = MAX, V_{IN} = 2 V$			40	μA
I_{IL}	Input low current	$V_{DD} = MAX, V_{IN} = 0.4 V$	-40			μA
CI	Receiver input capacitance				4	pF
t _r	Rise time, TXCLK, TKMSB, TKLSB, TXD[015]	0.7 V to 1.9 V, C = 5 pF, See Figure 7		1		ns
t _f	Fall time, TXCLK, TKMSB, TKLSB, TXD[015]	1.9 V to 0.7 V, C = 5 pF, See Figure 7		1		ns
t _{su}	TXD[015], TKMSB, TKLSB setup to ↑ TXCLK	See Figure 7	1.5			ns
t _h	TXD, TKMSB, TKLSB hold to ↑ TXCLK	See Figure 7	0.4			ns

TLK2711A SLLS908B-JULY 2008-REVISED OCTOBER 2012



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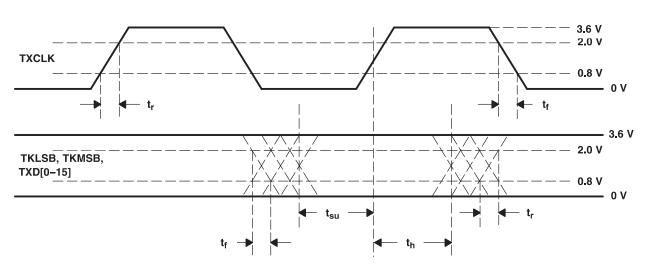


Figure 7. TTL Data Input Valid Levels for AC Measurements



TTL OUTPUT SWITCHING CHARACTERISTICS

over recommended operating conditions (unless otherwise noted)

	PARAMETER	TEST CONDITIONS	MIN	TYP	MAX	UNIT
V _{OH}	High-level output voltage	$I_{OH} = -1 \text{ mA}, V_{DD} = \text{MIN}$	2.10	2.3		V
V _{OL}	Low-level output voltage	$I_{OL} = 1 \text{ mA}, V_{DD} = \text{MIN}$	GND	0.25	0.5	V
$t_{r(slew)}$	Slew rate (rising), magnitude of RXCLK, RKLSB, RKMSB, RXD[015]	0.8 V to 2 V, C = 5 pF, See Figure 8	0.5			V/ns
$t_{\rm f(slew)}$	Slew rate (falling), magnitude of RXCLK, RKLSB, RKMSB, RXD[015]	0.8 V to 2 V, C = 5 pF, See Figure 8	0.5			V/ns
	RXD[0 15] RKMSB RKLSB setup to ↑ RXCLK	50% voltage swing, TXCLK = 80 MHz, See Figure 8	3			
t _{su}	tsu 015], RKMSB,	50% voltage swing, TXCLK = 135 MHz, See Figure 8	2.5			ns
		50% voltage swing, TXCLK = 80 MHz, See Figure 8				
t _h	RXD[0 15] RKMSB RKLSB hold to ↑ RXCLK	50% voltage swing, TXCLK = 135 MHz, See Figure 8	2.5			ns

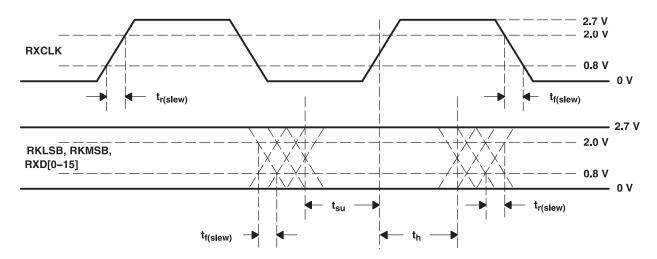


Figure 8. TTL Data Output Valid Levels for AC Measurements

TLK2711A

SLLS908B-JULY 2008-REVISED OCTOBER 2012

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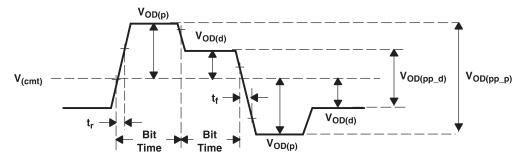
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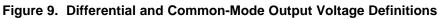
EXAS

TRANSMITTER/RECEIVER CHARACTERISTICS

	PARAMETER	TEST CONDITIONS	MIN	NOM	MAX	UNIT
V	Preemphasis V _{OD} , direct,	$R_t = 50\Omega$, PREM = high, dc-coupled, See Figure 9	655	800	1100	mV
V _{OD(p)}	$V_{OD(p)} = VTXP - VTXN $	Rt = 50Ω , PREM = low, dc-coupled, See Figure 9	590	740	1050	IIIV
M	Differential peak-to-peak output voltage	$R_t = 50\Omega$, PREM = high, dc-coupled, See Figure 9	1310	1600	2200	
V _{OD(pp_p)}	with preemphasis	Rt = 50Ω , PREM = low, dc-coupled, See Figure 9	1180	1480	2100	mV _{PP}
V _{OD(d)}	Deemphais output voltage, VTXP–VTXN	$R_t = 50 \ \Omega$, DC-coupled, See Figure 9	540	650	950	mV
V _{OD(pp_d)}	Differential, peak-to-peak output voltage with deemphasis	$R_t = 50\Omega$, dc-coupled, See Figure 9	1080	1300	1900	mV _{PP}
V _(cmt)	Transmit common mode voltage range, (VTXP + VTXN)/2	$R_t = 50\Omega$, See Figure 9	1000	1250	1400	mV
V _{ID}	Receiver input voltage differential, VRXP – VRXN		200		1600	mV
V _(cmr)	Receiver common mode voltage range, (VRXP + VRXN)/2		1000	1250	2250	mV
l _{lkg}	Receiver input leakage current		-10		10	μA
	Ci Receiver input capacitance				2	pF
	Carial data total jittar (paak to paak)	Differential output jitter at 2.7 Gbps, Random + deterministic, PRBS pattern		0.20		UI ⁽¹⁾
	Serial data total jitter (peak-to-peak)	Differential output jitter at 1.5 Gbps, Random + deterministic, PRBS pattern	0.16			UN /
t _t , t _f	Differential output signal rise, fall time (20% to 80%)	$R_L = 50\Omega, C_L = 5 \text{ pF}, \text{ See Figure 9}$		150		ps
	Jitter tolerance	Differential input jitter, random + deterministic, PRBS pattern at zero crossing	0.60			UI
t _{d(Tx latency)}	Tx latency	See Figure 3	34		38	bits
t _{d(Rx latency)}	Rx latency	See Figure 6	76		107	bits

(1) UI is the time interval of one serialized bit.





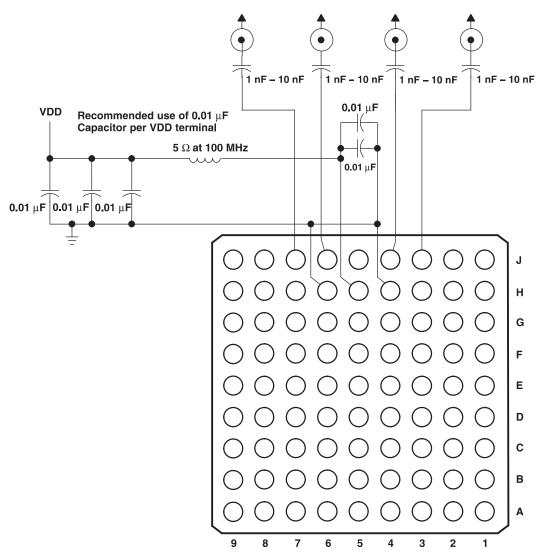


THERMAL INFORMATION

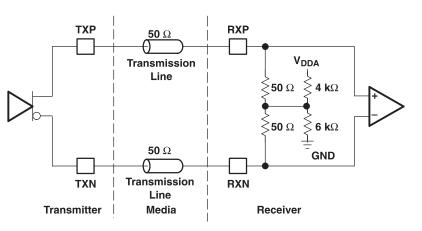
THERMAL CHARACTERISTICS

	PARAMETER	TEST CONDITIONS	MIN	TYP	MAX	UNIT
		Board-mounted, no air flow, high conductivity TI recommended test board, chip soldered or greased to thermal land		21.47		
R _{θJA}	Junction-to-free-air thermal resistance	Board-mounted, no air flow, high conductivity TI recommended test board with thermal land but no solder or grease thermal connection to thermal land		42.20		°C/W
		Board-mounted, no air flow, JEDEC test board		75.88		
		Board-mounted, no air flow, high conductivity TI recommended test board, chip soldered or greased to thermal land		0.38		
R _{θJC}	Junction-to-case thermal resistance	Board-mounted, no air flow, high conductivity TI recommended test board with thermal land but no solder or grease thermal connection to thermal land		0.38		°C/W
		Board-mounted, no air flow, JEDEC test board		7.8		

APPLICATION INFORMATION









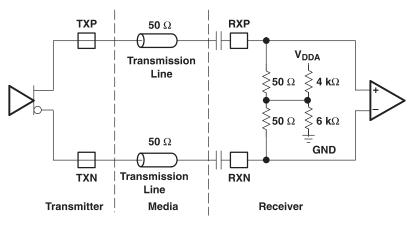


Figure 12. High-Speed I/O AC-Coupled Mode



REVISION HISTORY

Changes from Original (July 2008) to Revision A	Page
Changed invalid K-codes to correct typographical errors (Table 4)	11
Changes from Revision A (September 2009) to Revision B	Page
• Changed the TYP and MAX values of $V_{OD(p)}$, $V_{OD(pp_p)}$, $V_{OD(d)}$, and $V_{OD(pp_d)}$ in the TRANSMITTER/	RECEIVER

CHARACTERISTICS table 16



12-Aug-2016

PACKAGING INFORMATION

Orderable Device	Status	Package Type	•	Pins	•	Eco Plan	Lead/Ball Finish	MSL Peak Temp	Op Temp (°C)	Device Marking	Samples
	(1)		Drawing		Qty	(2)	(6)	(3)		(4/5)	
TLK2711AIRCP	LIFEBUY	HVQFP	RCP	64	160	Green (RoHS & no Sb/Br)	CU NIPDAU	Level-3-260C-168 HR	-40 to 85	TLK2711AI	
TLK2711AIRCPR	LIFEBUY	HVQFP	RCP	64	1000	Green (RoHS & no Sb/Br)	CU NIPDAU	Level-3-260C-168 HR	-40 to 85	TLK2711AI	
TLK2711AJRZQE	LIFEBUY	BGA MICROSTAR JUNIOR	ZQE	80		TBD	Call TI	Call TI	0 to 70	TLK2711A	

⁽¹⁾ The marketing status values are defined as follows:

ACTIVE: Product device recommended for new designs.

LIFEBUY: TI has announced that the device will be discontinued, and a lifetime-buy period is in effect.

NRND: Not recommended for new designs. Device is in production to support existing customers, but TI does not recommend using this part in a new design.

PREVIEW: Device has been announced but is not in production. Samples may or may not be available.

OBSOLETE: TI has discontinued the production of the device.

⁽²⁾ Eco Plan - The planned eco-friendly classification: Pb-Free (RoHS), Pb-Free (RoHS Exempt), or Green (RoHS & no Sb/Br) - please check http://www.ti.com/productcontent for the latest availability information and additional product content details.

TBD: The Pb-Free/Green conversion plan has not been defined.

Pb-Free (RoHS): TI's terms "Lead-Free" or "Pb-Free" mean semiconductor products that are compatible with the current RoHS requirements for all 6 substances, including the requirement that lead not exceed 0.1% by weight in homogeneous materials. Where designed to be soldered at high temperatures, TI Pb-Free products are suitable for use in specified lead-free processes.

Pb-Free (RoHS Exempt): This component has a RoHS exemption for either 1) lead-based flip-chip solder bumps used between the die and package, or 2) lead-based die adhesive used between the die and leadframe. The component is otherwise considered Pb-Free (RoHS compatible) as defined above.

Green (RoHS & no Sb/Br): TI defines "Green" to mean Pb-Free (RoHS compatible), and free of Bromine (Br) and Antimony (Sb) based flame retardants (Br or Sb do not exceed 0.1% by weight in homogeneous material)

⁽³⁾ MSL, Peak Temp. - The Moisture Sensitivity Level rating according to the JEDEC industry standard classifications, and peak solder temperature.

⁽⁴⁾ There may be additional marking, which relates to the logo, the lot trace code information, or the environmental category on the device.

(5) Multiple Device Markings will be inside parentheses. Only one Device Marking contained in parentheses and separated by a "~" will appear on a device. If a line is indented then it is a continuation of the previous line and the two combined represent the entire Device Marking for that device.

⁽⁶⁾ Lead/Ball Finish - Orderable Devices may have multiple material finish options. Finish options are separated by a vertical ruled line. Lead/Ball Finish values may wrap to two lines if the finish value exceeds the maximum column width.



12-Aug-2016

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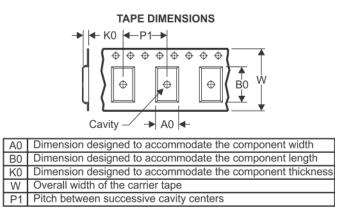
PACKAGE MATERIALS INFORMATION

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TAPE AND REEL INFORMATION





QUADRANT ASSIGNMENTS FOR PIN 1 ORIENTATION IN TAPE



*All dimensions are nominal	

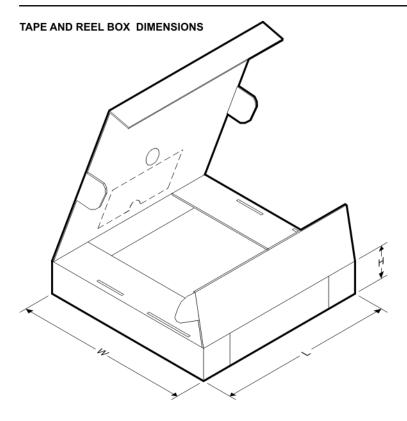
Device	Package Type	Package Drawing		SPQ	Reel Diameter (mm)	Reel Width W1 (mm)	A0 (mm)	B0 (mm)	K0 (mm)	P1 (mm)	W (mm)	Pin1 Quadrant
TLK2711AIRCPR	HVQFP	RCP	64	1000	330.0	24.4	13.0	13.0	1.5	16.0	24.0	Q2

TEXAS INSTRUMENTS

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PACKAGE MATERIALS INFORMATION

4-Oct-2012

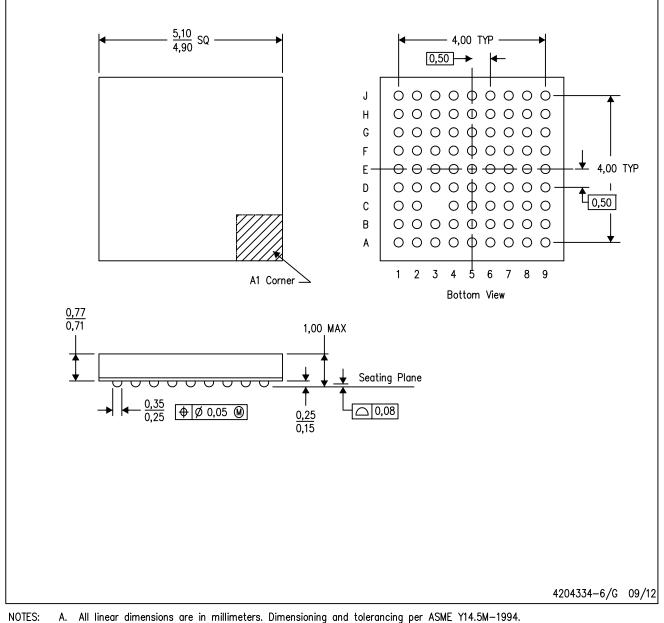


*All dimensions are nominal

Device	Package Type	Package Drawing	Pins	SPQ	Length (mm)	Width (mm)	Height (mm)
TLK2711AIRCPR	HVQFP	RCP	64	1000	367.0	367.0	45.0

ZQE (S-PBGA-N80)

PLASTIC BALL GRID ARRAY



A. All linear dimensions are in minimeters. Dimensioning and to
B. This drawing is subject to change without notice.

C. Falls within JEDEC MO-225

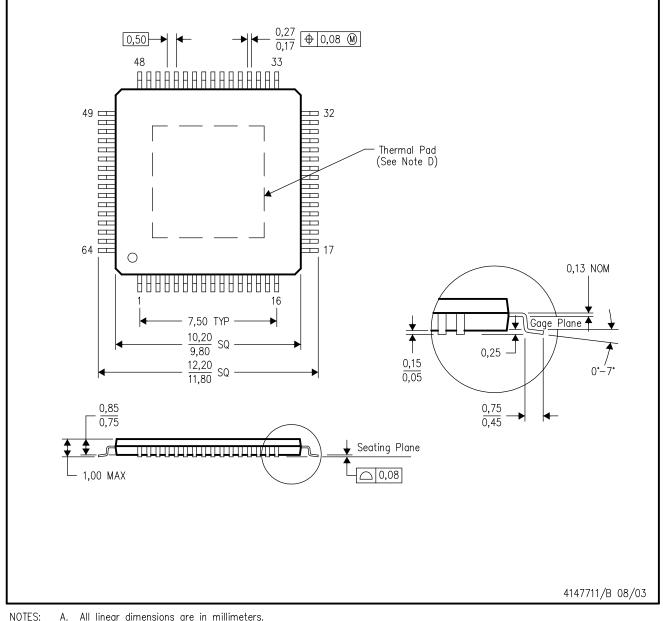
D. This is a Pb-free solder ball design.

MicroStar Junior is a trademark of Texas Instruments.



RCP (S-PQFP-G64)

PowerPAD[™] PLASTIC QUAD FLATPACK



Α. All linear dimensions are in millimeters.

- This drawing is subject to change without notice. Β.
- Body dimensions do not include mold flash or protrusion C.
- This package is designed to be soldered to a thermal pad on the board. Refer to Technical Brief, PowerPad D. Thermally Enhanced Package, Texas Instruments Literature No. SLMA002 for information regarding recommended board layout. This document is available at www.ti.com <http://www.ti.com>.
- E. Falls within JEDEC MS-026

PowerPAD is a trademark of Texas Instruments.





THERMAL PAD MECHANICAL DATA

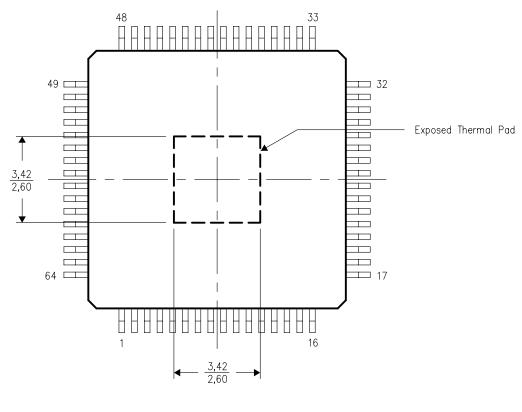
RCP (S-PQFP-G64)

THERMAL INFORMATION

This PowerPAD [™] package incorporates an exposed thermal pad that is designed to be attached directly to an external heatsink. The thermal pad must be soldered directly to the printed circuit board (PCB). After soldering, the PCB can be used as a heatsink. In addition, through the use of thermal vias, the thermal pad can be attached directly to the appropriate copper plane shown in the electrical schematic for the device, or alternatively, can be attached to a special heatsink structure designed into the PCB. This design optimizes the heat transfer from the integrated circuit (IC).

For additional information on the PowerPAD package and how to take advantage of its heat dissipating abilities, refer to Technical Brief, PowerPAD Thermally Enhanced Package, Texas Instruments Literature No. SLMA002 and Application Brief, PowerPAD Made Easy, Texas Instruments Literature No. SLMA004. Both documents are available at www.ti.com.

The exposed thermal pad dimensions for this package are shown in the following illustration.

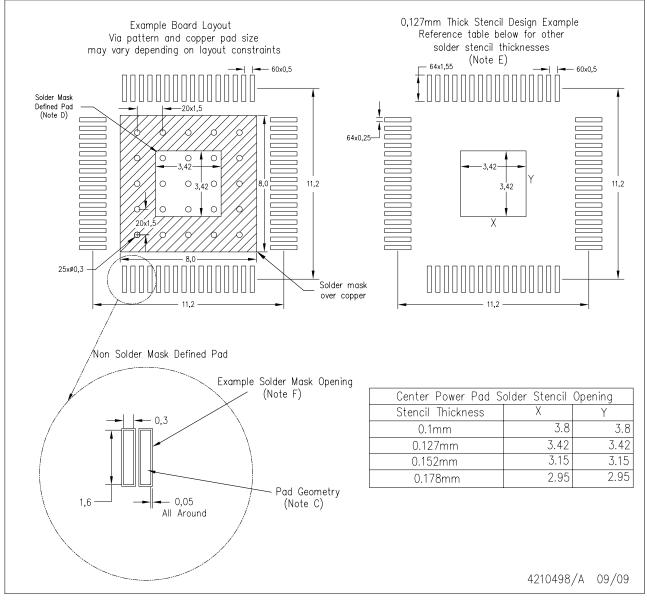


Top View

NOTE: All linear dimensions are in millimeters

Exposed Thermal Pad Dimensions

RCP (R−PVQFN−G64)PowerPAD[™]



NOTES:

- A. All linear dimensions are in millimeters.
 - B. This drawing is subject to change without notice.
 - C. Publication IPC-7351 is recommended for alternate designs.
 - D. This package is designed to be soldered to a thermal pad on the board. Refer to Technical Brief, PowerPad Thermally Enhanced Package, Texas Instruments Literature No. SLMA002, SLMA004, and also the Product Data Sheets for specific thermal information, via requirements, and recommended board layout. These documents are available at www.ti.com http://www.ti.com>.
 - E. Laser cutting apertures with trapezoidal walls and also rounding corners will offer better paste release. Customers should contact their board assembly site for stencil design recommendations. Refer to IPC 7525 for stencil design considerations.
 - F. Customers should contact their board fabrication site for recommended solder mask tolerances and via tenting options for vias placed in the thermal pad.



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